Single N-Channel Power MOSFET

40 V, 240 A, 0.72 m Ω

Features

- Small Footprint (TOLL) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V_{DSS}	40	V
Gate-to-Source Voltage	Gate-to-Source Voltage			±20	V
Continuous Drain Current R _{θJC} (Notes 1, 3)	Steady State	T _C = 25°C	I _D	240	Α
Power Dissipation	Steady T _C = 25°C		P_{D}	357.1	W
R _{θJC} (Note 1)	State	T _C = 100°C		178.6	
Continuous Drain	Steady State	T _C = 25°C	I _D	53.3	Α
Current R _{0JA} (Notes 1, 2, 3)	State	T _C = 100°C		37.7	
Power Dissipation	Steady	T _C = 25°C	P_{D}	3.5	W
H _{θJA} (Notes 1, 2)	R _{0JA} (Notes 1, 2) State			1.7	
Pulsed Drain Current	T _C = 25	°C, t _p = 10 μs	I _{DM}	2113	Α
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +175	°C
Source Current (Body Diode)			Is	100	Α
Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 79 A, L = 0.2 mH)			E _{AS}	624	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			T _L	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. The entire application environment impacts the thermal resistance values

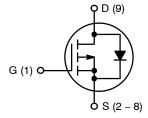
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted. Current is limited by bondwire configuration.
- 2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- 3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.



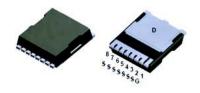
ON Semiconductor®

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V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
40 V	0.72 m Ω @ 10 V	80 A
	0.98 mΩ @ 4.5 V	50 A



N-CHANNEL MOSFET



H-PSOF8L CASE 100CU

MARKING DIAGRAM



&Z = Assembly Plant Code &3 - Numeric Date Code

K = Lot Code FDBL9403L = Specific Device Code

&3 = Numeric Date Code &K = Lot Code

ORDERING INFORMATION

See detailed ordering and shipping information on page 7 of this data sheet

Table 1. THERMAL CHARACTERISTICS

Symbol	Parameter	Value	Unit
$R_{ heta JC}$	Junction-to-Case - Steady State	0.42	°C/W
$R_{\theta JA}$	Junction-to-Ambient - Steady State (Note 4)	43	

^{4.} Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.

Table 2. ELECTRICAL CHARACTERISTICS (T_{.I} = 25°C unless otherwise noted)

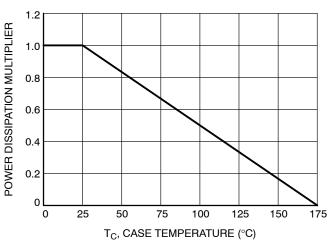
Symbol	Parameter	Test Condition	Min	Тур	Max	Unit
OFF CHARA	CTERISTICS					
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	40	-	-	V
V _{(BR)DSS} /T _J	Drain-to-Source Breakdown Voltage Temperature Coefficienct		-	22.5	-	mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 25^{\circ}\text{C}$ $V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 175^{\circ}\text{C}$	- -	-	1	μA mA
I _{GSS}	Zero Gate Voltage Drain Current	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	-	-	±100	nA
ON CHARAC	CTERISTICS (Note 5)					
V _{GS(th)}	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	1	1.75	3	V
V _{GS(th)} /T _J	Threshold Temperature Coefficient		-	-5.6	-	mV/°C
R _{DS(on)}	Drain-to-Source On Resistance	V _{GS} = 10 V, I _D = 80 A	-	0.59	0.72	mΩ
		V _{GS} = 4.5 V, I _D = 40 A	-	0.76	0.98	
CHARGES,	CAPACITANCES & GATE RESISTANCE			•		•
C _{iss}	Input Capacitance	V_{GS} = 0 V, f = 1 MHz, V_{DS} = 20 V	-	14100	-	pF
C _{oss}	Output Capacitance			4070	-	
C _{rss}	Reverse Transfer Capacitance		_	300	-	
R _g	Gate Resistance	V _{GS} = 0.5 V, f = 1 MHz	-	3.3	-	Ω
Q _{g(tot)} Total G	Total Gate Charge	V _{GS} = 4.5 V, V _{DS} = 32 V, I _D = 80 A	-	97	-	nC
		V _{GS} = 10 V, V _{DS} = 32 V, I _D = 80 A	-	203	_	
Q _{g(th)}	Threshold Gate Charge	V _{GS} = 0 V to 1 V	-	13	_	
Q _{gs}	Gate-to-Source Gate Charge	V _{DD} = 32 V, I _D = 80 A	-	40	_	
Q _{gd}	Gate-to-Drain "Miller" Charge		_	27	_	
V _{GP}	Plateau Voltage	1		3	-	V
SWITCHING	CHARACTERISTICS			•		
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 20 \text{ V}, I_D = 80 \text{ A},$	_	21	-	ns
t _r	Turn-On Rise Time	V_{GS} = 10 V, R_{GEN} = 6 Ω	_	42	-	
t _{d(off)}	Turn-Off Delay Time		_	288	-	
t _f	Turn-Off Fall Time	1		101	-	
DRAIN-SOU	RCE DIODE CHARACTERISTICS					
V_{SD}	Source-to-Drain Diode Voltage	I _{SD} = 80 A, V _{GS} = 0 V	-	0.79	1.25	V
		I _{SD} = 40 A, V _{GS} = 0 V	-	0.75	1.2	1
t _{rr}	Reverse Recovery Time	$V_{GS} = 0 \text{ V}, \text{ dI}_{SD}/\text{dt} = 100 \text{ A}/\mu\text{s}, \text{ I}_{S} = 80 \text{ A}$	_	96	-	ns
t _a	Charge Time		_	46	_	1
t _b	Discharge Time		_	50	-	1
Q _{rr}	Reverse Recovery Charge		_	130	_	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

5. Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.

6. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



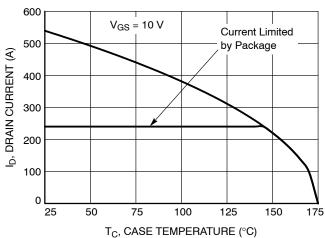


Figure 1. Normalized Power Dissipation vs.

Case Temperature

Figure 2. Maximum Continuous Drain Current vs. Case Temperature

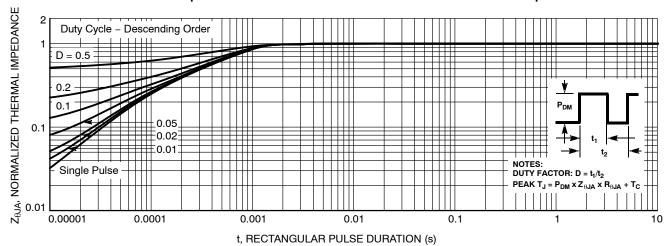


Figure 3. Normalized Maximum Transient Thermal Impedance

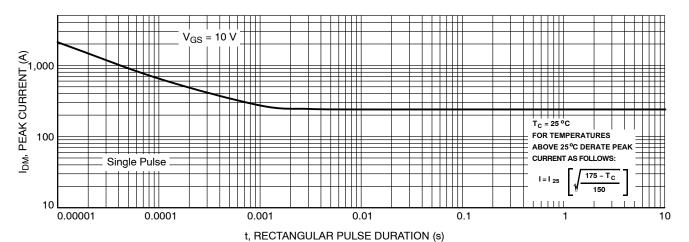


Figure 4. Peak Current Capability

TYPICAL CHARACTERISTICS

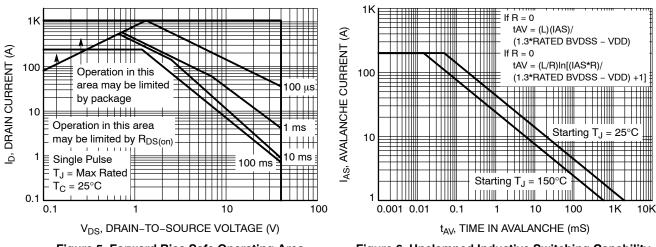


Figure 5. Forward Bias Safe Operating Area

Figure 6. Unclamped Inductive Switching Capability

Note: Refer to ON Semiconductor Application Notes AN7514 and AN7515

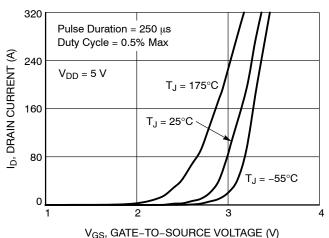


Figure 7. Transfer Characteristics

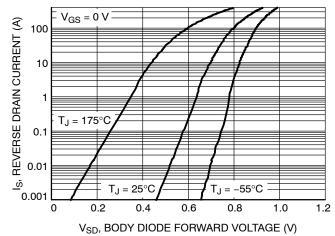


Figure 8. Forward Diode Characteristics

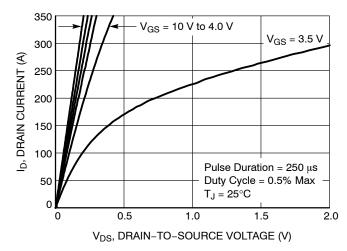


Figure 9. Saturation Characteristics

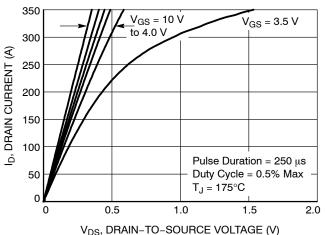


Figure 10. Saturation Characteristics

TYPICAL CHARACTERISTICS

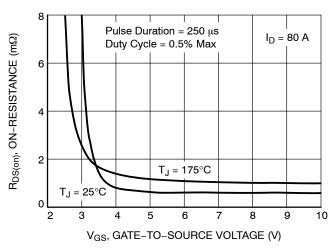


Figure 11. R_{DS(on)} vs. Gate Voltage

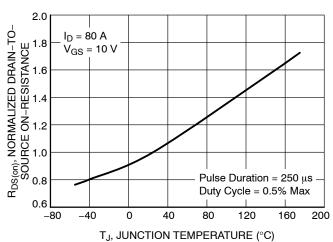


Figure 12. Normalized R_{DS(on)} vs. Junction

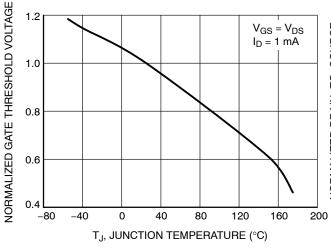


Figure 13. Normalized Gate Threshold Voltage vs. Temperature

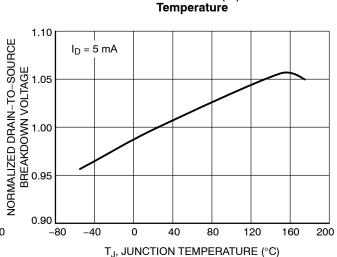


Figure 14. Normalized Drain-to-Source Breakdown Voltage vs. Junction Temperature

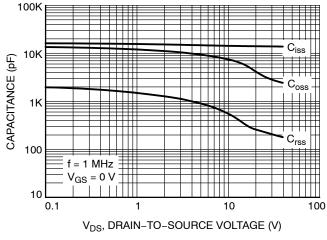


Figure 15. Capacitance vs. Drain-to-Source Voltage

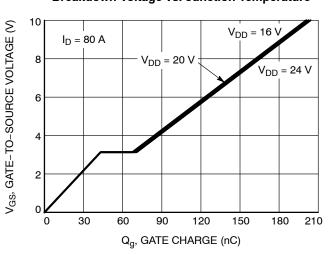
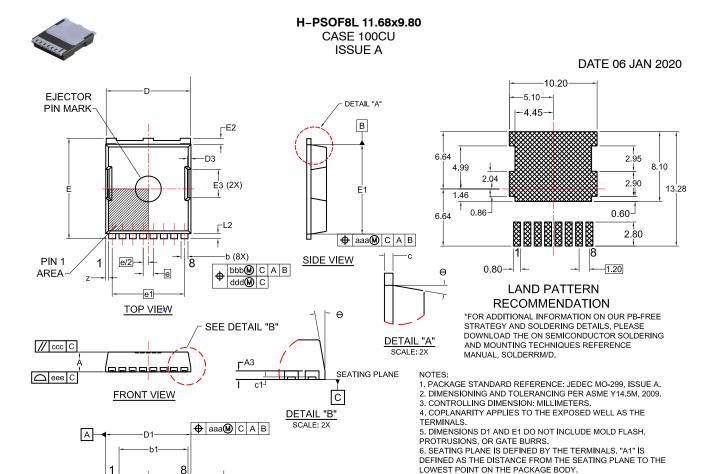


Figure 16. Gate Charge vs. Gate-to-Source Voltage

PACKAGE MARKING AND ORDERING INFORMATION

Device	Marking	Package	Reel Size	Tape Width	Quantity
FDBL9403L-F085	FDBL9403L	H-PSOF8L (Pb-Free / Halogen Free)	13″	24 mm	2000 Units



	MILLIMETERS			
DIM				
	MIN.	NOM.	MAX.	
Α	2.20	2.30	2.40	
A3	0.40	0.50	0.60	
b	0.70	0.80	0.90	
b1		8.00 REF		
С	0.40	0.50	0.60	
c1	0.10			
D	9.70	9.80	9.90	
D1	9.80	9.90	10.00	
D2	4.73 BSC			
D3	0.40 REF			
D4	;	3.75 BSC	;	
D5	_	1.20		
D6	7.40	7.50	7.60	
D7	(8.30)			
E	11.58	11.68	11.78	
E1	10.28	10.38	10.48	
E2	0.60	0.70	0.80	
E3	3.30 REF			

E4

DIM	MILLIMETERS				
J	MIN.	NOM.	MAX.		
е		1.20 BSC			
e/2	(0.60 BSC	;		
e1		3.40 BSC	;		
K	1.50	1.57	1.70		
L	1.90	2.00	2.10		
L2	0.50	0.60	0.70		
Z	0.35 REF				
θ	0° 12°				
aaa	0.20				
bbb	0.25				
ccc	0.20				
ddd		0.20			
eee		0.10			
E5		3.30	_		
E6		0.65	_		
E7	7.15 REF				
E8	6.55 6.65 6.75				
E9	5.89 BSC				
E10	5.19 BSC				

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

2.60

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H.A.A.A.A.A.A

|--D5 (3X)

D4 -

-D7

BOTTOM VIEW

E10

E9

| E8

L

-0.10 E4 (2X)

E5 (2X) ⊢E6 (2X)

Α

WW

ZΖ

GENERIC
MARKING DIAGRAM*

AYWWZZ

XXXXXXXX

= Year

= Work Week

XXXX = Specific Device Code

= Assembly Location

= Assembly Lot Code

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